

Notice of References Cited	Application/Control No. 10/584,218		Applicant(s)/Patent Under Reexamination MIYACHI ET AL.	
	Examiner Sean P. Cullen		Art Unit 1795	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0166409	08-2004	Takada et al.	429/218.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1231654 A1	08-2002	European Patent	IKEDA et al.	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Machine translation of JP 09245771 A, Incue et al., 09/1997
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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